

3SK38A

SILICON N CHANNEL MOS TYPE (INDUSTRIAL APPLICATIONS)

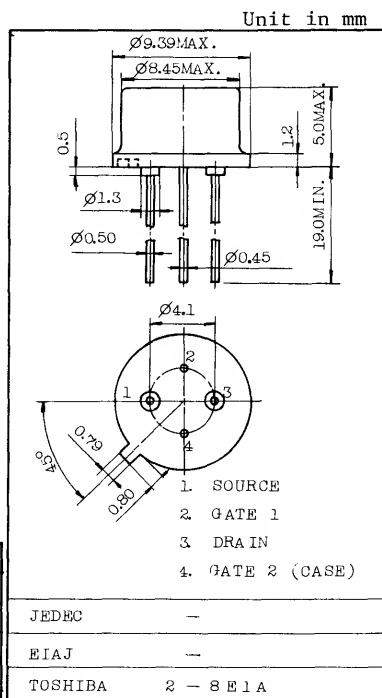
CHOPPER CIRCUIT APPLICATIONS.
SWITCHING CIRCUIT APPLICATIONS.
IMPEDANCE CONVERTER APPLICATIONS.

FEATURES :

- Ultra Small Drain-Source Thermoemotive Force
: $V_{emf} = 1.3 \mu V/^{\circ}C$ (Typ.)
- High Resistance Ratio
: $r_{DS(ON)} = 500\Omega$ (Max.) at. $V_{G1S}=3V$
: $r_{DS(OFF)} = 100M\Omega$ (Min.) at. $V_{G1S}=0V$
- Low Gate Capacitance and Offset
: $C_D = 2.5pF$ (Max.), $\Delta C_G = 0.3pF$ (Max.)
- Contains Gates Protection Diode.

MAXIMUM RATINGS (Ta=25°C)

CHARACTERISTIC	SYMBOL	RATING	UNIT
Drain-Source Voltage	V_{DSS}	20	V
Gate 1-Source Voltage	V_{G1SS}	± 12	V
Gate 2-Source Voltage	V_{G2SS}	-20	V
Drain-Source Current	I_{DS}	10	mA
Drain Power Dissipation	P_D	200	mW
Channel Temperature	T_{ch}	125	°C
Storage Temperature Range	T_{stg}	-65 ~ 125	°C

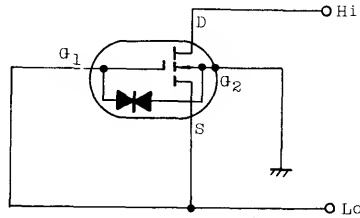


Weight : 1.1g

ELECTRICAL CHARACTERISTICS (Ta=25°C)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Gate Leakage Current	I_{G1SS}	$V_{G1S}=12V, V_{G2S}=0, V_{DS}=0$	-	-	25	nA
	I_{G2SS}	$V_{G1S}=12V, V_{G2S}=0, V_{DS}=0$	-	-	-25	nA
Drain Current	I_{DSS}	$V_{G1S}=0, V_{G2S}=0, V_{DS}=6V$	-	-	50	nA
Gate-Source Cut-off Voltage	$V_{GS(OFF)}$	$V_{G2S}=0, V_{DS}=6V, I_D=50nA$	0	-	3	V
Forward Transfer Admittance	$ Y_{fs} $	$V_{G1S}=3V, V_{G2S}=0, V_{DS}=6V, f=1kHz$	0.35	-	-	mS
Gate-Drain Capacitance	C_{GD}	Fig. 1	-	-	2.5	pF
Gate-Source Capacitance	C_{GS}	Fig. 2	-	-	2.5	pF
Differential Gate Capacitance	C_D	$ C_{GD}-C_{GS} $	-	-	0.3	pF
Drain-Source ON Resistance	$r_{DS(ON)}$	$V_{G1S}=3V, V_{G2S}=0, V_{DS}=10mV$	-	-	500	Ω
Drain-Source OFF Resistance	$r_{DS(OFF)}$	$V_{G1S}=0, V_{G2S}=0, V_{DS}=\pm 10mV$	100	-	-	M Ω
Drain-Source Thermoemotive Force	V_{emf}	$V_{G1S}=3V, V_{G2S}=0, T_a=0\sim 55^{\circ}C$	-	1.3	2	$\mu V/^{\circ}C$
Switching Time	Turn-on Time	t_{on}	-	50	-	ns
	Turn-off Time	t_{off}	-	900	-	

Fig.1 C_{G1D} TEST CIRCUIT

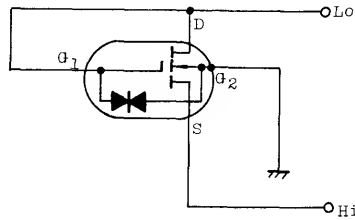


CAPACITANCE BRIDGE

$f = 1\text{MHz}$

$V_{G1S} = 0$

Fig.2 C_{G1S} TEST CIRCUIT

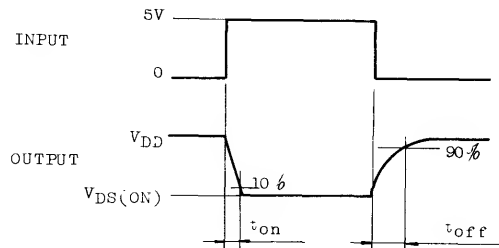
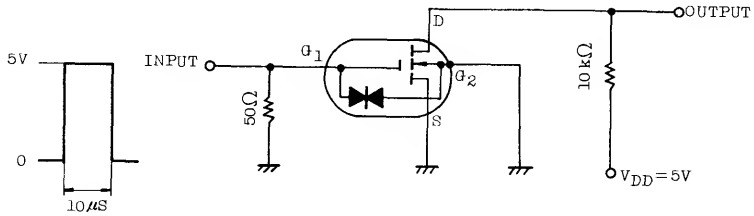


CAPACITANCE BRIDGE

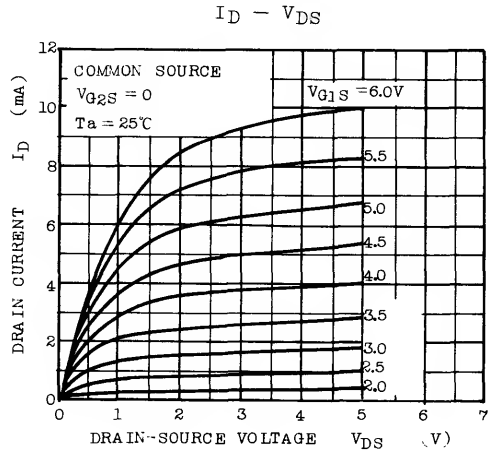
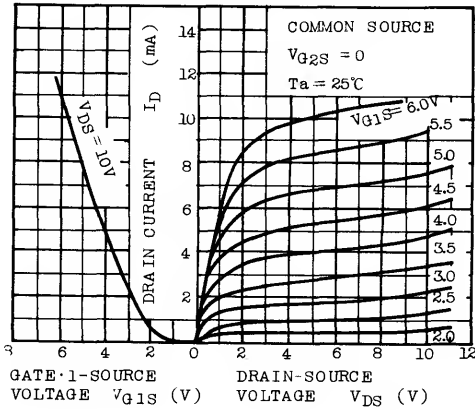
$f = 1\text{MHz}$

$V_{G1D} = 0$

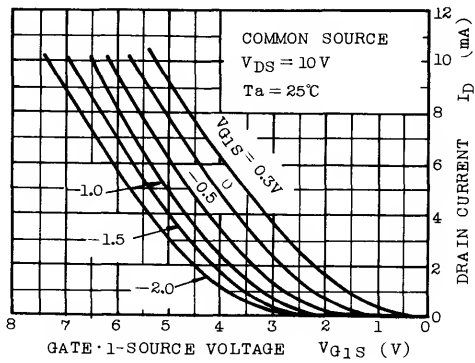
Fig.3 SWITCHING TIME TEST CIRCUIT



STATIC CHARACTERISTICS



$I_D - V_{G1S}$



$|y_{fs}| - I_D$

